

Search Notes**Application/Control No.**

10/702,551

Examiner

Mathieu D. Vargot

**Applicant(s)/Patent under
Reexamination**

LEE ET AL.

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner
updated	above	11/6/2009	MDV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR